Machine Learning for Industry

Lecture 3 - Classification and Learning Principles

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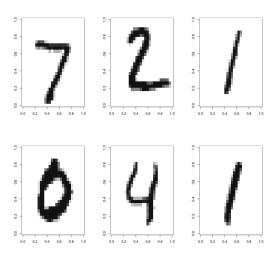




Outline

- Intro to classification
- **■** *k*-nearest neighbor
- Classification trees and forests
- Logistic regression
- Maximum likelihood
- Naive Bayes
- Bayesian learning and regularization

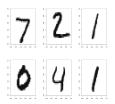
Classifying handwritten digits



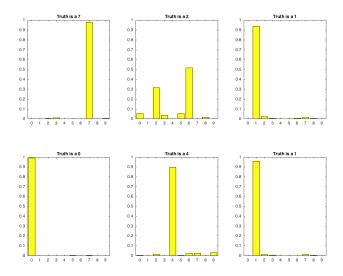
Classifying handwritten digits

- Raw data: gray intensity (0-255) in the $28 \times 28 = 784$ pixels.
- Training data: 60000 images. Test data: 10000 images.
- **Simple features**: 784 pixel intensity covariates.
- Multi-class problem: predict class $k \in \{0, 1, ..., 9\}$.
- Multinomial regression

$$\Pr(\mathsf{Digit} = k | \mathsf{features}) = \frac{\exp\left(w_{0,k} + w_{1,k}x_1 + \ldots + w_{784,k}x_{784}\right)}{\sum_{j=0}^9 \exp\left(w_{0,j} + w_{1,j}x_1 + \ldots + w_{784,j}x_{784}\right)}$$



Classifying handwritten digits



Handwritten digits 10000 training examples

		Truth									
		0	1	2	3	4	5	6	7	8	9
	0	958	0	8	3	1	7	10	0	7	9
	1	0	1116	3	1	1	5	3	23	9	9
	2	1	2	920	21	5	5	9	22	7	2
	3	0	2	10	915	0	34	1	1	14	10
Decision	4	1	0	16	0	908	9	10	12	11	46
	5	11	3	3	31	2	795	15	1	31	12
	6	6	4	20	2	11	16	909	0	13	1
	7	1	0	15	13	4	5	0	938	9	22
	8	2	8	34	16	2	12	1	5	859	5
	9	0	0	3	8	48	4	0	26	14	893

Handwritten digits 60000 training examples

		Truth									
		0	1	2	3	4	5	6	7	8	9
	0	966	0	8	1	1	7	9	2	4	6
	1	0	1121	1	1	0	2	3	13	7	7
	2	2	2	957	13	5	4	4	21	7	0
	3	0	2	9	947	0	29	1	3	12	10
Decision	4	0	0	12	1	940	5	5	9	8	32
	5	6	1	3	19	1	816	9	1	24	9
	6	4	4	13	1	7	12	926	0	10	1
	7	1	0	9	10	2	2	0	954	5	13
	8	1	4	17	11	2	10	1	3	892	4
	9	0	1	3	6	24	5	0	22	5	927

Al is getting better over time - handwritten digits

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	Logistic	K-nearest	SVM	3-layer NN	ConvNet
Error rate:	12%	5%	1.4%	1.53%	0.4%

1000

Taday

Detecting fraudulent banknotes

- Dataset with 1372 photographed banknotes. 610 fake.
- Raw data: $400 \times 400 = 160000$ gray-scale pixels.
- The 160000 pixel variables are condensed to four features:
 - variance of Wavelet Transformed image
 - skewness of Wavelet Transformed image
 - curtosis of Wavelet Transformed image
 - entropy of image
- Deep learning on raw images?



Detecting fraudulent banknotes

- 1000 images for training. Predictions on 372 test images.
- Logistic regression

$$\Pr(\text{Fraud} = \text{True}|\text{features}) = \frac{\exp(w_0 + w_1 x_1 + \dots + w_4 x_4)}{1 + \exp(w_0 + w_1 x_1 + \dots + w_4 x_4)}$$

- **Decision**: signal fraud if Pr(Fraud = True|Features) > 0.5.
- Confusion matrix

		Truth			
		No fraud	Fraud		
Decision	No Fraud	208	1		
	Fraud	3	160		

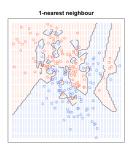
k-nearest neighbor

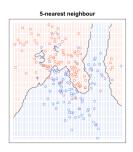
k-nearest classifier: classify according to the majority vote:

$$\hat{y}(\mathbf{x}) = \begin{cases} 0 & \text{if } f(\mathbf{x}) \le 0.5\\ 1 & \text{if } f(\mathbf{x}) > 0.5 \end{cases}$$

where

$$f(\mathbf{x}) = \frac{\text{\#class 1 among the } k \text{ nearest neighbors}}{k}$$





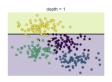
Classification trees

Multi-class classification trees. Probability of class k in rectangle R_m with N_m observations

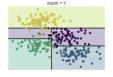
$$\hat{\rho}_{mk} = \frac{1}{N_m} \sum_{x_i \in R_m} I(y_i = k), \quad k = 1, ..., K.$$

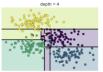
Predicted class in rectangle R_m : majority vote

$$\hat{k}(m) = \arg\max_{k} \hat{p}_{mk}$$









Classification trees

Prune the tree by collapsing non-terminal nodes to minimize

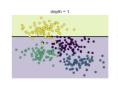
$$\sum_{i=1}^{n} \ell\left(y_{i}, \hat{k}(m)\right) + \eta |T|$$

Mis-classification rate as loss function:

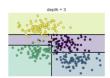
$$\sum_{i=1}^{n} \ell\left(y_{i}, \hat{k}(m)\right) = \sum_{m=1}^{|T|} \sum_{x_{i} \in R_{m}} I\left(y_{i} \neq \hat{k}(m)\right) = \sum_{m=1}^{|T|} N_{m} \left(1 - \hat{\rho}_{m,\hat{k}(m)}\right)$$

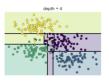
Cross-entropy as loss function:

$$\sum_{i=1}^{n} \ell\left(y_{i}, \hat{k}(m)\right) = \sum_{m=1}^{|T|} N_{m} \left(-\sum_{k=1}^{K} \hat{p}_{m\hat{k}} \log \hat{p}_{m\hat{k}}\right)$$







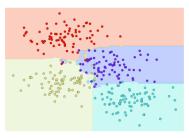


Random forest and XGBoost classification

- Random Forest can be directly used for classification.
- XGBoost
 - ▶ second approximation of a general loss function $\sum_{i=1}^{n} \ell(y_i, \hat{y})$
 - loss function must be differentiable (e.g. cross-entropy).

Single tree

Random forest



Classification - logistic regression

Logistic classification

$$\Pr(Y_i = 1 | \mathbf{x}) = \frac{\exp(\mathbf{x}_i^T \mathbf{w})}{1 + \exp(\mathbf{x}_i^T \mathbf{w})}$$

- **Discriminative** model direct modeling of Pr(Y = 1|x)
- Multi-class logistic classification: $c \in \{1, 2, ..., C\}$

$$\Pr(Y_i = c | \mathbf{x}) = \frac{\exp(\mathbf{x}_i^T \mathbf{w}_c)}{\sum_{k=1}^C \exp(\mathbf{x}_i^T \mathbf{w}_k)} \text{ with } \mathbf{w}_1 = 0.$$

- How to learn the weights, w?
 - ▶ Quadratic fitting function: $n^{-1} \sum_{i=1}^{n} (y_i x_i^T \mathbf{w})^2$?
 - Fit weights to maximize accuracy on training data?
- Maximum likelihood!

Classification - logistic regression

Logistic regression is a linear model:

$$\log \frac{\Pr(Y_i = 1 | \boldsymbol{x})}{\Pr(Y_i = 0 | \boldsymbol{x})} = \boldsymbol{x}_i^T \boldsymbol{w}$$

and so has linear decision boundary.



- Get non-linear boundaries by including polynomials in x.
- General non-linear logistic regression

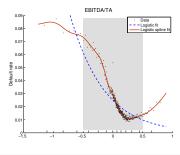
$$\Pr(Y_i = 1 | \mathbf{x}) = \frac{\exp(f(\mathbf{x}_i))}{1 + \exp(f(\mathbf{x}_i))}$$

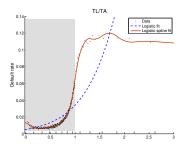
where $f(\mathbf{x})$ is some potentially non-linear function, e.g.

- Deep neural nets
- Gaussian Processes

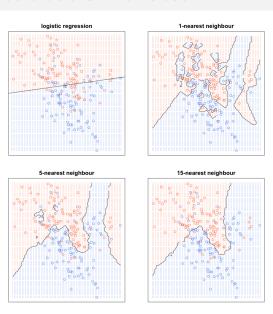
Predicting firm bankruptcy

- Data from \sim 250, 000 Swedish firms (aktiebolag).
- Features: profits, liquidity, debt + macro variables.
- "Big data" ⇒ non-linearities are visible by the eye.
- Model: logistic regression with additive splines.
- Substantially improved predictive performance with splines.





Bias-variance trade-off revisited



The likelihood function

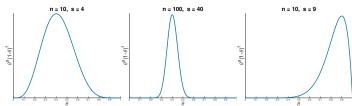
Let $Y_1, ..., Y_n$ be binary variables (e.g. coin flips) with

$$Pr(Y = 0) = 1 - \theta$$
 and $Pr(Y = 1) = \theta$.

- **Data summary**: s successes (y = 1) and f failures (y = 0).
- Likelihood function

$$L(\theta) = p(y_1, ..., y_n | \theta) = p(y_1 | \theta) \cdot \cdot \cdot p(y_n | \theta) = \theta^s (1 - \theta)^f$$

- The likelihood, $L(\theta)$, is:
 - ▶ the probability of the observed data
 - considered as a function of the parameter.
- Plot $p(y_1, ..., y_n | \theta)$ as a function of θ for a given dataset.



Maximum likelihood estimation

Maximum likelihood estimator (MLE) - max the likelihood

$$\hat{\theta}_{\mathit{ML}} = \arg\max_{\theta} L(\theta).$$

- General fitting method. Applies to all probabilistic models.
- Example: binary independent data. Easier on log-scale

$$\log L(\theta) = s \log \theta + f \log(1 - \theta)$$

Compute derivative, set it equal to zero and solve:

$$\frac{\partial}{\partial \theta} \log L(\theta) = \frac{s}{\theta} - \frac{f}{1 - \theta} = 0$$

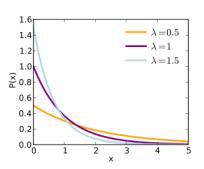
gives $\hat{\theta}_{ML} = s/n$, the proportion of successes.

- Regression with Gaussian errors: ML = Least squares.
- MLE minimizes the cross-entropy between data and model.

Exponential distribution

- **Exponential random variable** $Y \sim \text{Exp}(\lambda)$.
- **Continuous** variable with **positive support** $Y \in (0, \infty)$.
- Probability density function (pdf)

$$f(y) = \lambda \exp(-\lambda y).$$



Mean $\mathbb{E}(Y) = \frac{1}{\lambda}$ and variance $\mathbb{V}(Y) = \frac{1}{\lambda^2}$.

ML for exponential data

Likelihood function based on pdfs:

$$f(y_1, ..., y_n) = \prod_{i=1}^n f(y_i) = \prod_{i=1}^n \lambda \exp(-\lambda y_i) = \lambda^n \exp\left(-\lambda \sum_{i=1}^n y_i\right)$$

Log-likelihood

$$\log f(y_1, ..., y_n) = n \log \lambda - \lambda \sum_{i=1}^n y_i$$

ML estimator

$$\frac{\partial}{\partial \lambda} \log f(y_1, ..., y_n) = \frac{n}{\lambda} - \sum_{i=1}^n y_i = 0$$

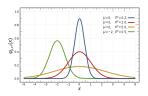
gives

$$\hat{\lambda}_{ML} = \frac{n}{\sum_{i=1}^{n} y_i} = \frac{1}{\bar{y}}.$$

Normal distribution

- Normal random variable $Y \sim N(\mu, \sigma^2)$ for $Y \in (-\infty, \infty)$
- Probability density function

$$f(y) = \frac{1}{\sqrt{2\pi\sigma^2}} \exp\left(-\frac{1}{2\sigma^2}(y-\mu)^2\right).$$



- Mean $\mathbb{E}(Y) = \mu$ and variance $\mathbb{V}(Y) = \sigma^2$.
- ML estimates: $\hat{\mu}_{ML} = \bar{y}$ and $\hat{\sigma}_{ML}^2 = \sum_{i=1}^n (y_i \bar{y})^2 / n$.

ML for truncated exponential data

Truncated exponential data: $Y^* \sim \text{Exp}(\lambda)$, but we observe

$$Y = \begin{cases} Y^* & \text{if } Y^* < c \\ c & \text{if } Y^* \ge c \end{cases}$$

- If $Y \sim \text{Exp}(\lambda)$, then $\Pr(Y_i > c) = 1 \Pr(Y_i < c) = e^{-\lambda c}$.
- Likelihood function based on pdfs:

$$f(y_1,...,y_n) = \prod_{i \in \mathcal{U}} f(y_i) \prod_{i \notin \mathcal{U}} \Pr(Y_i > c) = \lambda^{n_u} \exp\left(-\lambda \sum_{i \in \mathcal{U}} y_i\right) e^{-\lambda(n-n_u)c}$$

Maximum likelihood estimator

$$\frac{\partial}{\partial \lambda} \log f(y_1, ..., y_n) = \frac{n_u}{\lambda} - \sum_{i \in \mathcal{U}} y_i - (n - n_u)c = 0$$

which gives

$$\frac{1}{\hat{\lambda}_{MI}} = \frac{\sum_{i \in \mathcal{U}} y_i}{n_u} + \frac{n - n_u}{n_u} c.$$

Maximum likelihood for logistic regression

Logistic regression

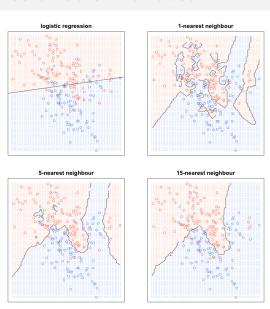
$$\Pr(Y_i = y_i | \boldsymbol{x}) = \frac{\exp(\boldsymbol{x}_i^T \boldsymbol{w})^{y_i}}{1 + \exp(\boldsymbol{x}_i^T \boldsymbol{w})}$$

Likelihood

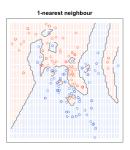
$$p(y_1,\ldots,y_n|\mathbf{x}_1,\ldots,\mathbf{x}_n,\mathbf{w}) = \prod_{i=1}^n \frac{\exp\left(\mathbf{x}_i^T\mathbf{w}\right)^{y_i}}{1 + \exp\left(\mathbf{x}_i^T\mathbf{w}\right)}$$

- No closed form solution. Iteratively reweighted least squares.
- MLbyOptimization.ipynb for numerically computing $\hat{\boldsymbol{w}}_{ML}$.
- Gradient $\nabla_{\mathbf{w}} \log p(y_1, \dots, y_n | \mathbf{x}_1, \dots, \mathbf{x}_n, \mathbf{w})$ easily computed and speeds up optimization (gradient descent).
- Big data: **Stochastic gradient descent** for large *n*.
- Automatic differentiation.

Bias-Variance trade-off revisited

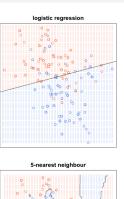


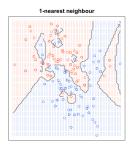




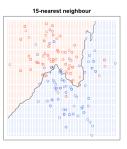


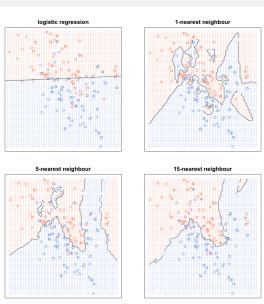




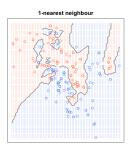


















Naive Bayes

- Aim: p(k|x) probability of class k given features x.
- Bayes' theorem

$$p(k|\mathbf{x}) \propto p(\mathbf{x}|k)p(k)$$

- p(k) estimated from training data by relative frequencies.
- p(x|k) can high-dimensional. Hard to estimate.
- Naive Bayes: features are assumed independent

$$p(\mathbf{x}|k) = \prod_{j=1}^{p} p(x_j|k)$$

Predicting text. Binary features: existence of specific words.

$$\hat{\rho} \, (\mathsf{has}(\mathsf{ball}) | \mathsf{news}) = \frac{\mathsf{Number of news articles containing the word 'ball'}}{\mathsf{Number of news articles}}$$

Bayesian learning

- Subjective probability. Subjective degree of belief.
- The statement $\Pr(10\mathsf{th}\,\mathsf{decimal}\,\mathsf{of}\,\pi=9)=0.1$ makes sense.
- Example: Binary data $\Pr(Y_i = 1) = \theta$.
- Prior distribution: $p(\theta) = \text{Beta}(\alpha, \beta)$.
- Likelihood

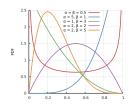
$$p(y_1,...,y_n|\theta) = \theta^s(1-\theta)^f.$$

Posterior distribution by Bayes' theorem:

$$p(\theta|y_1,\ldots,y_n) \propto \underbrace{p(y_1,\ldots,y_n|\theta)p(\theta)}_{\text{likelihood}}$$
 prior

Posterior for Bernoulli data

$$\theta|y_1,\ldots,y_n\sim \operatorname{Beta}(\alpha+s,\beta+f)$$



Bayesian regression

Regularization prior

$$w_i | \sigma^2 \stackrel{iid}{\sim} N\left(0, \frac{\sigma^2}{\lambda}\right)$$

 Posterior distribution is Gaussian with ridge regression as mean

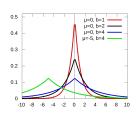
$$\tilde{\mathbf{w}} = \left(\mathbf{X}^T \mathbf{X} + \lambda I\right)^{-1} \mathbf{X}^T \mathbf{y}$$

Shrinkage toward zero

As
$$\lambda \to \infty$$
, $\tilde{\mathbf{w}} \to 0$

Lasso is equivalent to posterior mode under Laplace prior

$$\beta_i | \sigma^2 \stackrel{iid}{\sim} \text{Laplace} \left(0, \frac{\sigma^2}{\lambda} \right)$$



Evaluating a classifier - confusion matrix

Confusion matrix:

		Truth			
		Positive	Negative		
Decision	Positive	tp	fp		
	Negative	fn	tn		

- tp = true positive, fp = false positive fn = false negative, tn = true negative.
- Example:

		Truth			
		Fraud	No Fraud		
Decision	Fraud	tp	fp		
	No Fraud	fn	tn		

Evaluating a classifier - Accuracy

Accuracy is the proportion of correctly classified items

$$\mathsf{Accuracy} = \frac{\mathit{tp} + \mathit{tn}}{\mathit{tp} + \mathit{tn} + \mathit{fn} + \mathit{fp}}$$

		Truth		
		Positive	Negative	
Decision	Positive	tp	fp	
	Negative	fn	tn	

Evaluating a classifier - Precision

Precision is the proportion of truly positive items among those signaled as positive:

$$Precision = \frac{tp}{tp + fp}$$

		Iruth			
		Positive	Negative		
Decision	Positive	tp	fp		
	Negative	fn	tn		

- High precision:
 - trustworthy positives
 - people pointed out as fraudulent are almost always frauds.

Evaluating a classifier - Recall

Recall is the proportion of signaled positive items among those that are truly positive:

$$Recall = \frac{tp}{tp + fn}$$

		Truth			
		Positive	Negative		
Decision	Positive	tp	fp		
	Negative	fn	tn		

- High recall:
 - will find the positive items.
 - fraudulents will be caught.
- Recall is also called the True Positive Rate (TPR)
- There is a trade-off between Precision and Recall.

Evaluating a classifier - False Positive Rate

False Positive Rate (FPR) is the proportion of signaled positive items among those that are truly negative:

$$FPR = \frac{fp}{fp + tn}$$

		Truth			
		Positive	Negative		
Decision	Positive	tp	fp		
	Negative	fn	tn		

- Low FPR:
 - will very rarely signal a positive for a negative item.
 - people will not be falsely accused of fraud.

Evaluating a classifier - ROC curve

- Precision and recall depends on the decision threshold.
- Pr(Spam|text in an email) = 0.9. Do we send it to the spam-box?
- Is Pr(Fraud|features) > 0.5 a good decision threshold?
- Optimal decisions depend on the consequences.

 Decision theory.
- **ROC-curve**: Receiver Operating Characteristic.
- ROC: Plots the true positive rate (TPR) against the false positive rate (FPR) at various thresholds.
- **AUC** = Area Under Curve. Area under the ROC curve.

Evaluating a classifier - ROC

